# **MOSFET** - Power, Dual **N-Channel, Logic Level** 60 V, 65 mΩ, 12 A

#### **Features**

- Small Footprint (5x6 mm) for Compact Designs
- Low R<sub>DS(on)</sub> to Minimize Conduction Losses
- Low Capacitance to Minimize Driver Losses
- 175°C Operating Temperature
- NVMFD5489NLWF Wettable Flank Option for Enhanced Optical
- AEC-Q101 Qualified and PPAP Capable
- This is a Pb-Free Device

### **MAXIMUM RATINGS** (T<sub>J</sub> = 25°C unless otherwise noted)

| Parameter   |                  |                            | Symbol                            | Value         | Unit |
|---|------------------|----------------------------|-----------------------------------|---------------|------|
| Drain-to-Source Voltage   |                  |                            | $V_{DSS}$                         | 60            | V    |
| Gate-to-Source Voltage  |                  |                            | $V_{GS}$                          | ±20           | V    |
| Continuous Drain Current $R_{\Psi J-mb}$  |                  | $T_{mb} = 25^{\circ}C$     | I <sub>D</sub>                    | 12            | Α    |
| (Notes 1, 2, 3, 4)  | Steady           | $T_{mb} = 100^{\circ}C$    |                                   | 8.8           |      |
| Power Dissipation   | State            | T <sub>mb</sub> = 25°C     | $P_{D}$                           | 23.4          | W    |
| R <sub>ΨJ-mb</sub> (Notes 1, 2, 3)  |                  | T <sub>mb</sub> = 100°C    |                                   | 11.7          |      |
| Continuous Drain Current R <sub>0JA</sub>   |                  | T <sub>A</sub> = 25°C      | I <sub>D</sub>                    | 4.5           | Α    |
| (Notes 1, 3 & 4)  | Steady           | T <sub>A</sub> = 100°C     |                                   | 3.2           |      |
| Power Dissipation   | State            | T <sub>A</sub> = 25°C      | $P_{D}$                           | 3.0           | W    |
| R <sub>θJA</sub> (Notes 1 & 3)  |                  | T <sub>A</sub> = 100°C     |                                   | 1.5           |      |
| Pulsed Drain Current  | $T_A = 25^\circ$ | °C, t <sub>p</sub> = 10 μs | I <sub>DM</sub>                   | 62            | Α    |
| Operating Junction and Storage Temperature  |                  |                            | T <sub>J</sub> , T <sub>stg</sub> | -55 to<br>175 | °C   |
| Source Current (Body Diode)   |                  | I <sub>S</sub>             | 22                                | Α             |      |
| Single Pulse Drain–to–Source Avalanche Energy ( $T_J$ = 25°C, $I_{L(pk)}$ = 19.5 A, L = 0.1 mH, $R_G$ = 25 $\Omega$ ) |                  |                            | E <sub>AS</sub>                   | 19            | mJ   |
| Lead Temperature for Soldering Purposes (1/8" from case for 10 s)   |                  |                            | TL                                | 260           | °C   |

Stresses exceeding those listed in the Maximum Ratings table may damage the device. If any of these limits are exceeded, device functionality should not be assumed, damage may occur and reliability may be affected.

### THERMAL RESISTANCE MAXIMUM RATINGS (Note 1)

| Parameter   | Symbol             | Value | Unit |
|---|--------------------|-------|------|
| Junction-to-Mounting Board (top) - Steady<br>State (Notes 2, 3) | R <sub>ΨJ−mb</sub> | 6.4   |      |
| Junction-to-Ambient - Steady State (Note 3)                     |                    | 50    | °C/W |
| Junction-to-Ambient - Steady State (min footprint)              | $R_{\theta JA}$    | 161   |      |

- The entire application environment impacts the thermal resistance values shown, they are not constants and are only valid for the particular conditions noted.
- 2. Psi  $(\Psi)$  is used as required per JESD51-12 for packages in which substantially less than 100% of the heat flows to single case surface.

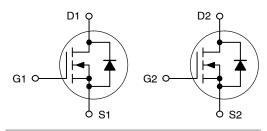


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| V <sub>(BR)DSS</sub> | R <sub>DS(on)</sub> MAX | I <sub>D</sub> MAX |
|----------------------|-------------------------|--------------------|
| 60 V                 | 65 mΩ @ 10 V            | 12 A               |
|                      | 79 mΩ @ 4.5 V           | 127                |

#### **Dual N-Channel**



### **DFN8 5x6** (SO8FL) **CASE 506BT**

ZZ

## **MARKING DIAGRAM**

D1 D1 S<sub>1</sub> G1 D1 XXXXXX S2 D2 **AYWZZ** G2 D2 D2 D2

XXXXXX = 5489NL

(NVMFD5489NL) or

5489LW

(NVMFD5489NLWF) = Assembly Location

= Year = Work Week W

#### **ORDERING INFORMATION**

= Lot Traceability

| OTIDETHING INTO OTHER PROPERTY. |                   |                       |  |  |
|---------------------------------|-------------------|-----------------------|--|--|
| Device                          | Package           | Shipping <sup>†</sup> |  |  |
| NVMFD5489NLT1G                  | DFN8<br>(Pb-Free) | 1500/<br>Tape & Reel  |  |  |
| NVMFD5489NLT3G                  | DFN8<br>(Pb-Free) | 5000/<br>Tape & Reel  |  |  |
| NVMFD5489NLWFT1G                | DFN8<br>(Pb-Free) | 1500/<br>Tape & Reel  |  |  |
| NVMFD5489NLWFT3G                | DFN8<br>(Pb-Free) | 5000/<br>Tape & Reel  |  |  |

†For information on tape and reel specifications, including part orientation and tape sizes, please refer to our Tape and Reel Packaging Specification Brochure, BRD8011/D.

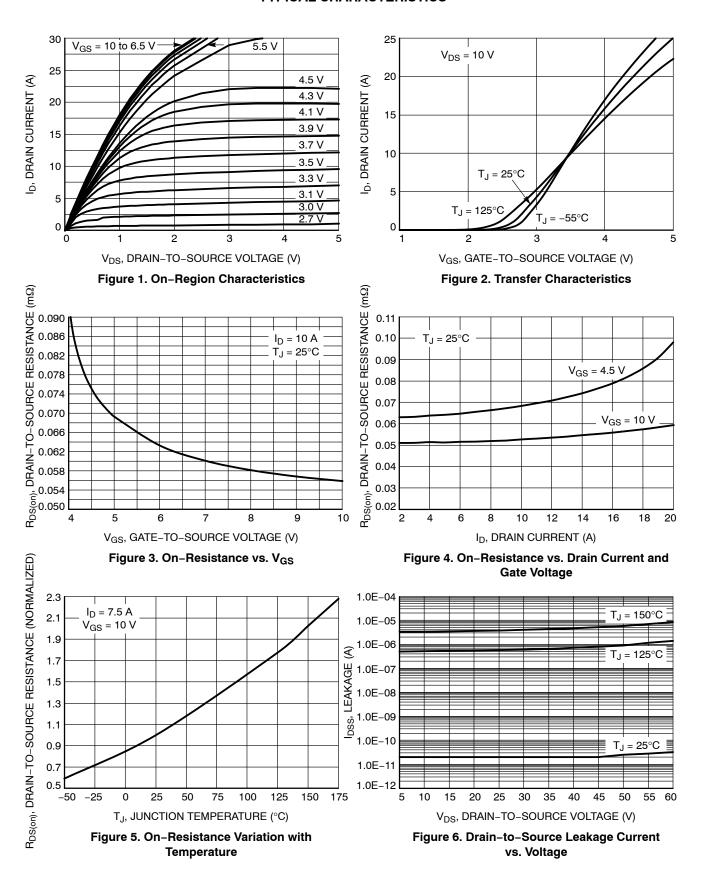
| 3.<br>4. | Surface-mounted on FR4 board using a 650 mm <sup>2</sup> , 2 oz. Cu pad. Continuous DC current rating. Maximum current for pulses as long as 1 second are higher but are dependent on pulse duration and duty cycle. |
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### **ELECTRICAL CHARACTERISTICS** (T<sub>J</sub> = 25°C unless otherwise specified)

| Parameter  | Symbol                               | Test Cond   | tion   | Min  | Тур   | Max  | Unit  |
|--|--------------------------------------|---|--|------|-------|------|-------|
| OFF CHARACTERISTICS  | •                                    |   | •  |      |       |      |       |
| Drain-to-Source Breakdown Voltage                            | V <sub>(BR)DSS</sub>                 | V <sub>GS</sub> = 0 V, I <sub>D</sub> = 250 μA  |  | 60   |       |      | V     |
| Drain-to-Source Breakdown Voltage<br>Temperature Coefficient | V <sub>(BR)DSS</sub> /T <sub>J</sub> | Reference to<br>I <sub>D</sub> = 250  |  |      | 67    |      | mV/°C |
| Zero Gate Voltage Drain Current                              | I <sub>DSS</sub>                     | V <sub>GS</sub> = 0 V,<br>V <sub>DS</sub> = 60 V                                      | T <sub>J</sub> = 25°C<br>T <sub>J</sub> = 125°C            |      |       | 1.0  | μΑ    |
| Gate-to-Source Leakage Current                               | I <sub>GSS</sub>                     | V <sub>DS</sub> = 0 V, V <sub>GS</sub>  | ű  |      |       | ±100 | nA    |
| ON CHARACTERISTICS (Note 5)                                  |                                      |   | L  |      |       |      | ı     |
| Gate Threshold Voltage                                       | V <sub>GS(TH)</sub>                  | $V_{GS} = V_{DS}, I_D =$  | = 250 μA   | 1.5  |       | 2.5  | V     |
| Negative Threshold Temperature Coefficient                   | V <sub>GS(TH)</sub> /T <sub>J</sub>  | Reference to  | 25°C   |      | 4.86  |      | mV/°C |
| Drain-to-Source On Resistance                                | R <sub>DS(on)</sub>                  | V <sub>GS</sub> = 10 V, I <sub>D</sub>  | , = 15 A   |      | 52    | 65   | mΩ    |
|  | ,                                    | V <sub>GS</sub> = 4.5 V, I <sub>D</sub>   | , = 7.5 A  |      | 66    | 79   |       |
| CHARGES AND CAPACITANCES                                     |                                      |   |  |      |       |      | •     |
| Input Capacitance  | C <sub>iss</sub>                     |   |  |      | 330   |      | pF    |
| Output Capacitance   | C <sub>oss</sub>                     | V <sub>GS</sub> = 0 V, f = 1.0 MH   | V <sub>GS</sub> = 0 V, f = 1.0 MHz, V <sub>DS</sub> = 25 V |      |       |      |       |
| Reverse Transfer Capacitance                                 | C <sub>rss</sub>                     |   | ŀ  |      | 39    |      |       |
| Total Gate Charge  | Q <sub>G(TOT)</sub>                  |   |  |      | 12.4  |      | nC    |
| Threshold Gate Charge  | Q <sub>G(TH)</sub>                   | V <sub>GS</sub> = 10 V, V <sub>DS</sub>   |  | 0.31 |       |      |       |
| Gate-to-Source Charge  | $Q_{GS}$                             | I <sub>D</sub> = 6 A  |  |      | 1.3   |      |       |
| Gate-to-Drain Charge   | $Q_{GD}$                             |   |  |      | 4.74  |      |       |
| SWITCHING CHARACTERISTICS (No                                | ote 6)                               |   |  |      |       |      |       |
| Turn-On Delay Time   | t <sub>d(on)</sub>                   |   |  |      | 7     |      | ns    |
| Rise Time  | t <sub>r</sub>                       | $V_{GS} = 10 \text{ V}, V_{DS}$   | s = 48 V,  |      | 11    |      |       |
| Turn-Off Delay Time  | t <sub>d(off)</sub>                  | $V_{GS} = 10 \text{ V}, V_{DS}$<br>$I_{D} = 6 \text{ A}, R_{G} = 10 \text{ A}$        | 2.5 Ω  |      | 31    |      |       |
| Fall Time  | t <sub>f</sub>                       |   | ŀ  |      | 21    |      |       |
| DRAIN-SOURCE DIODE CHARACTE                                  | RISTICS                              |   |  |      |       |      | -     |
| Forward Diode Voltage  | $V_{SD}$                             | V <sub>GS</sub> = 0 V,  | T <sub>J</sub> = 25°C                                      |      | 0.83  | 1.2  | V     |
|  |                                      | I <sub>S</sub> = 10 A   | T <sub>J</sub> = 125°C                                     |      | 0.71  |      |       |
| Reverse Recovery Time  | t <sub>RR</sub>                      |   | 1  |      | 24.2  |      | ns    |
| Charge Time  | ta                                   | $V_{GS} = 0 \text{ V, } d_{ S}/d_t = 100 \text{ A/}\mu\text{s,}$ $I_S = 10 \text{ A}$ |  |      | 20.2  |      | 1     |
| Discharge Time   | t <sub>b</sub>                       |   |  |      | 4.0   |      | 1     |
| Reverse Recovery Charge                                      | Q <sub>RR</sub>                      |   |  |      | 26.5  |      | nC    |
| PACKAGE PARASITIC VALUES                                     |                                      |   | •  |      |       |      |       |
| Source Inductance  | L <sub>S</sub>                       | T <sub>A</sub> = 25°C   |  |      | 0.93  |      | nH    |
| Drain Inductance   | L <sub>D</sub>                       |   |  |      | 0.005 |      | 1     |
| Gate Inductance  | L <sub>G</sub>                       |   |  |      | 1.84  |      | 1     |
| Gate Resistance  | R <sub>G</sub>                       |   |  |      | 12    |      | Ω     |

<sup>5.</sup> Pulse Test: pulse width = 300 μs, duty cycle ≤ 2%.
6. Switching characteristics are independent of operating junction temperatures.

#### TYPICAL CHARACTERISTICS



### **TYPICAL CHARACTERISTICS**

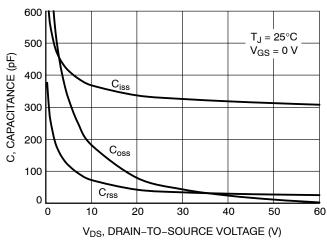


Figure 7. Capacitance Variation

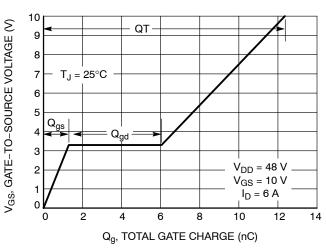


Figure 8. Gate-to-Source and Drain-to-Source Voltage vs. Total Charge

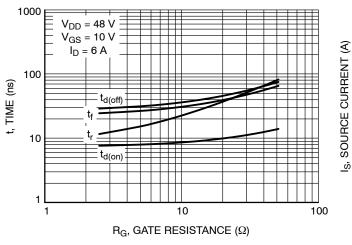


Figure 9. Resistive Switching Time Variation vs. Gate Resistance

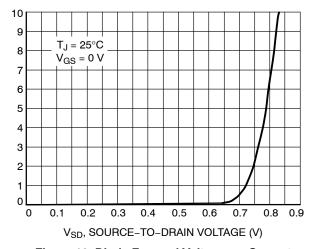


Figure 10. Diode Forward Voltage vs. Current

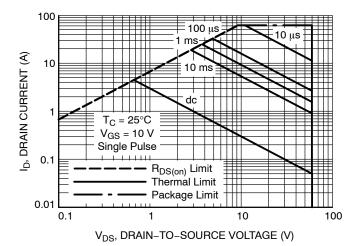


Figure 11. Maximum Rated Forward Biased Safe Operating Area

### **TYPICAL CHARACTERISTICS**

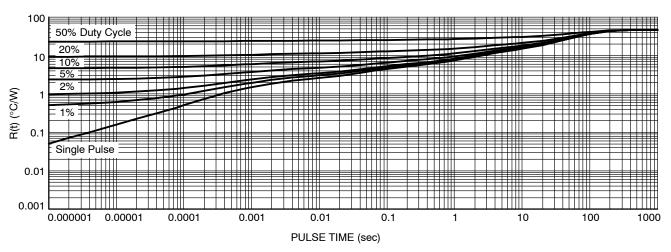
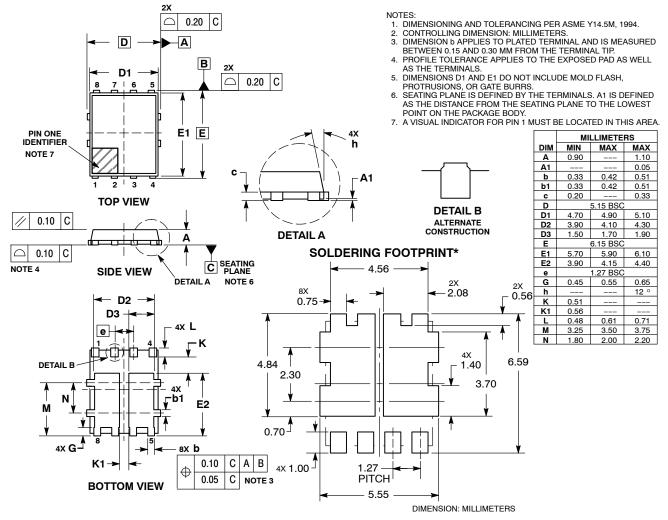


Figure 12. Thermal Response

#### PACKAGE DIMENSIONS

### DFN8 5x6, 1.27P Dual Flag (SO8FL-Dual)

CASE 506BT **ISSUE E** 



\*For additional information on our Pb-Free strategy and soldering details, please download the ON Semiconductor Soldering and Mounting Techniques Reference Manual, SOLDERRM/D.

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